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SERIAL NUMBER 10/807,692	FILING OR 371(c) DATE 03/24/2004 RULE	CLASS 326	GROUP ART UNIT 2819	ATTORNEY DOCKET NO. 0553-401
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APPLICANTS

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** CONTINUING DATA *****

None ITAN

** FOREIGN APPLICATIONS *****

JAPAN 2003-081666 03/25/2003

JAPAN 2003-137822 05/15/2003

OL ITAN

IF REQUIRED, FOREIGN FILING LICENSE GRANTED **

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Foreign Priority claimed	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR COUNTRY JAPAN	SHEETS DRAWING 17	TOTAL CLAIMS 21	INDEPENDENT CLAIMS 8
35 USC 119 (a-d) conditions met	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance				
Verified and Acknowledged	<i>Examiner's Signature</i> <i>ITAN</i> Initials				

ADDRESS

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TITLE

Circuit for inspecting semiconductor device and inspecting method

FILING FEE RECEIVED 1748	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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